



# **Dual N-Channel 20 V (D-S) MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
	0.168 at V <sub>GS</sub> = 4.5 V	1.3 <sup>a</sup>			
20	0.200 at V <sub>GS</sub> = 2.5 V	1.3 <sup>a</sup>	1.6 nC		
	0.250 at V <sub>GS</sub> = 1.8 V	1.3 <sup>a</sup>			

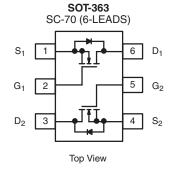
### **FEATURES**

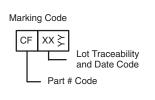
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- Compliant to RoHS Directive 2002/95/EC

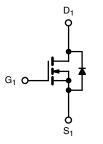


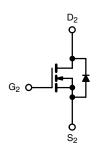
### **APPLICATIONS**

Load Switch for Portable Applications









Ordering Information: Si1988DH-T1-E3 (Lead (Pb)-free)

Si1988DH-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	20	V	
Gate-Source Voltage	$V_{GS}$	± 8			
	T <sub>C</sub> = 25 °C		1.3 <sup>a</sup>		
Continuous Dunin Comment (T. 150 °C)	T <sub>C</sub> = 70 °C	_	1.3 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	1.3 <sup>a, b, c</sup>		
	T <sub>A</sub> = 70 °C		1.3 <sup>a, b, c</sup>	Α	
Pulsed Drain Current	I <sub>DM</sub>	4			
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1	1.0		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.61 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		1.25		
Maximum Dayyar Dissipation	T <sub>C</sub> = 70 °C	В	0.8	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.74 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		0.47 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature	_	260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	130	170	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	80	100		

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 220  $^{\circ}\text{C/W}.$

### Si1988DH

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Static       Drain-Source Breakdown Voltage $V_{DS}$ $V_{GS} = 0 \text{ V}$ , $I_D = 250 \text{ μA}$ 20     V       Vps Temperature Coefficient $\Delta V_{DS}/T_L$ 19.7	<b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, unless otherwise noted								
	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
V <sub>DS</sub> Temperature Coefficient         AV <sub>DS</sub> (T) V <sub>OS(M)</sub> Temperature Coefficient         AV <sub>DS</sub> (T) V <sub>DS</sub> (T)         AV <sub>DS</sub> (T) V <sub>DS</sub>	Static					•	1		
V <sub>DS</sub> Temperature Coefficient         AV <sub>DS</sub> (T) V <sub>OS(M)</sub> Temperature Coefficient         AV <sub>DS</sub> (T) V <sub>DS</sub> (T)         AV <sub>DS</sub> (T) V <sub>DS</sub>	Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	20			V		
Vasion Temperature Coefficient         ΔVGS(m)/Tyl         VDS = VGS, ID = 250 μA         - 2.4         I         V           Gate-Source Threshold Voltage         VGS(m)         VDS = VGS, ID = 250 μA         0.4         1         V           Zero Gate Voltage Drain Current         IGSS         VDS = 0 V, VGS = 8 V          ± 100         ns           On-State Drain Current <sup>®</sup> ID(on)         VDS = 20 V, VGS = 0 V, TJ = 55 °C          10         A           On-State Drain Current <sup>®</sup> ID(on)         VDS = 5 V, VGS = 4 V, UD = 1.4 A          0.139         0.168         A           Drain-Source On-State Resistance <sup>®</sup> PRDS(on)         VDS = 4 V, UD = 1.4 A          0.165         0.200          0.205         0.250          0.205         0.250          0.205         0.250          0.205         0.250          0.205         0.250          0.205         0.250          0.205         0.250          0.205         0.250          0.205          0.205          0.205          0.205          0.205          0.205          0.205	V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		19.7		mV/°C		
Cate-Source Leakage	V <sub>GS(th)</sub> Temperature Coefficient		I <sub>D</sub> = 250 μA		- 2.4				
Gate-Source Leakage         I <sub>GSS</sub> V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 8 V	Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.4		1	V		
2   2   2   2   2   2   2   2   2   2	Gate-Source Leakage		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	ns		
No. State Drain Current <sup>a</sup>   1 <sub>D(m)</sub>   V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 4.5 V   4	Zara Cata Valtana Desir Commet		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	1		1			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Zero Gate voltage Drain Current		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10			
Drain-Source On-State Resistance <sup>a</sup> R <sub>DS</sub> (on)         V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 1.3 A         0.165         0.200         Ω           Forward Transconductance <sup>a</sup> g <sub>IS</sub> V <sub>DS</sub> = 4 V, I <sub>D</sub> = 0.4 A         0.205         0.250         Ω           Dynamic <sup>b</sup> Use of the properties of the	On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	4			Α		
V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 0.4 A   0.205   0.250		, ,	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1.4 A		0.139	0.168	1		
No.	Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 1.3 A		0.165	0.200	Ω		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		, ,	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 0.4 A		0.205	0.250	1		
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 4 \text{ V}, I_{D} = 1.4 \text{ A}$		4		S		
Output Capacitance         Coss Coss Reverse Transfer Capacitance         V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz         25         pF           Total Gate Charge         O <sub>G</sub> V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 8 V, I <sub>D</sub> = 1.6 A         2.7         4.1         A1.6         2.4         A1.6	Dynamic <sup>b</sup>	1				l .			
Output Capacitance         C <sub>Oss</sub> Reverse Transfer Capacitance         V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz         25	Input Capacitance	C <sub>iss</sub>			110		pF		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Output Capacitance	+	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		25				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance	C <sub>rss</sub>			11				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	T. 10 . 0	Q <sub>g</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 8 \text{ V}, I_D = 1.6 \text{ A}$		2.7	4.1	nC		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	lotal Gate Charge				1.6	2.4			
Gate-Drain Charge         Qgd         f = 1 MHz         0.25         □           Gate Resistance         Rg         f = 1 MHz         4         Ω           Turn-On Delay Time         tq(on)         VDD = 10 V, RL = 7.7 Ω         20         30           Fise Time         tf         10 = 1.3 A, VGEN = 4.5 V, Rg = 1 Ω         15         25           Fall Time         tf         10 = 1.3 A, VGEN = 8 V, Rg = 1 Ω         5         10         15           Turn-on Delay Time         tf         VDD = 10 V, RL = 7.7 Ω         11         20         15         25           Fall Time         tr         VDD = 10 V, RL = 7.7 Ω         11         20         15         10         15         15         10         15         10         15         10         15         10         15         10         15         10         11         20         11         20         11         20         11         20         11         20         11         20         11         11         20         11         11         11         11         11         11         11         11         12         11         11         12         12         12         14         14         14	Gate-Source Charge				0.3				
$ \begin{array}{ c c c c c c } \hline \text{Gate Resistance} & R_g & f = 1  \text{MHz} & 4 & \Omega \\ \hline \text{Turn-On Delay Time} & t_{d(on)} & & & & & 12 \\ \hline \text{Rise Time} & t_r & V_{DD} = 10  \text{V},  R_L = 7.7  \Omega & 20 & 30 \\ \hline \text{Turn-Off Delay Time} & t_d(off) & & & & 15 & 25 \\ \hline \text{Fall Time} & t_r & & & 10 & 15 \\ \hline \text{Turn-On Delay Time} & t_{d(on)} & & & & 5 & 10 \\ \hline \text{Rise Time} & t_r & & V_{DD} = 10  \text{V},  R_L = 7.7  \Omega & 11 & 20 \\ \hline \text{Turn-Off Delay Time} & t_r & & & 5 & 10 \\ \hline \text{Rise Time} & t_r & & & & 11 & 20 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & & 11 & 20 \\ \hline \text{Turn-Off Delay Time} & t_{r} & & & & & 11 & 20 \\ \hline \text{Fall Time} & t_r & & & & & 10 & 15 \\ \hline \textbf{Pall Time} & t_r & & & & & & 11 & 20 \\ \hline \textbf{Drain-Source Body Diode Characteristics} & & & & & & 11 & 20 \\ \hline \textbf{Drain-Source Body Diode Characteristics} & & & & & & 10 & 15 \\ \hline \textbf{Pulse Diode Forward Current} & I_S & & & & & & & & 1 & 4 \\ \hline \textbf{Body Diode Voltage} & & V_{SD} & & I_S = 1.3  \text{A},  V_{GS} = 0  \text{V} & & 0.8 & 1.2 & V \\ \hline \textbf{Body Diode Reverse Recovery Time} & & t_{rr} & & & & & 20 & 40 & nc \\ \hline \textbf{Reverse Recovery Fall Time} & & t_a & & & & & & & & & & & & & & & & & & &$	Gate-Drain Charge				0.25				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate Resistance	_	f = 1 MHz		4		Ω		
$ \begin{array}{ c c c c c }\hline \text{Rise Time} & t_r & V_{DD} = 10 \text{ V}, R_L = 7.7  \Omega \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & 15 & 25 \\ \hline \text{Fall Time} & t_f & 10 & 15 \\ \hline \text{Turn-on Delay Time} & t_{d(on)} & & & 5 & 10 \\ \hline \text{Rise Time} & t_r & V_{DD} = 10 \text{ V}, R_L = 7.7  \Omega \\ \hline \text{Turn-Off Delay Time} & t_r & & 5 & 10 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & 5 & 10 \\ \hline \text{Fall Time} & t_r & & & 11 & 20 \\ \hline \text{Turn-Off Delay Time} & t_{d(off)} & & & & 11 & 20 \\ \hline \text{Fall Time} & & t_r & & & 6 & 10 \\ \hline \textbf{Drain-Source Body Diode Characteristics} & & & & & & & \\ \hline \textbf{Continuous Source-Drain Diode Current} & I_S & T_C = 25  ^{\circ}\text{C} & & 1 & A \\ \hline \textbf{Pulse Diode Forward Current} & I_{SM} & & & 4 \\ \hline \textbf{Body Diode Reverse Recovery Time} & t_{rr} & & & 20 & 40 & ns \\ \hline \textbf{Body Diode Reverse Recovery Charge} & Q_{rr} & & & & 20 & 40 & ns \\ \hline \textbf{Reverse Recovery Fall Time} & t_a & & & & & & \\ \hline \end{array}$	Turn-On Delay Time				8	12	- ns		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time		$V_{DD} = 10 \text{ V, R}_1 = 7.7 \Omega$		20	30			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t <sub>d(off)</sub>			15	25			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time				10	15			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-on Delay Time				5	10			
Fall Time $tr$ $6$ $10$ Drain-Source Body Diode Characteristics  Continuous Source-Drain Diode Current $I_S$ $T_C = 25 ^{\circ}\text{C}$ $1$ A  Pulse Diode Forward Current $I_{SM}$ $4$ Body Diode Voltage $V_{SD}$ $I_S = 1.3  \text{A},  V_{GS} = 0 ^{\circ}\text{V}$ $0.8  1.2 ^{\circ}\text{V}$ Body Diode Reverse Recovery Time $t_{rr}$ Body Diode Reverse Recovery Charge $Q_{rr}$ Reverse Recovery Fall Time $t_a$ $I_F = 1.3  \text{A},  \text{dl/dt} = 100  \text{A/µs},  T_J = 25 ^{\circ}\text{C}$ $I_F = 1.3  \text{A},  \text{dl/dt} = 100  \text{A/µs},  T_J = 25 ^{\circ}\text{C}$	Rise Time				11	20			
	Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1.3 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$		10	15			
	Fall Time				6	10			
Pulse Diode Forward Current $I_{SM}$ Body Diode Voltage $V_{SD}$ Body Diode Reverse Recovery Time $t_{rr}$ Body Diode Reverse Recovery Charge $Q_{rr}$ Reverse Recovery Fall Time $t_a$ $I_{S} = 1.3 \text{ A}, V_{GS} = 0 \text{ V}$ $I_{S} = 1.3 \text{ A}, V_{$	Drain-Source Body Diode Characteristic	:s				l .	1		
Pulse Diode Forward Current $I_{SM}$ $4$ Body Diode Voltage $V_{SD}$ $I_S = 1.3 \text{ A}, V_{GS} = 0 \text{ V}$ $0.8  1.2  \text{ V}$ Body Diode Reverse Recovery Time $t_{rr}$ $20  40  \text{ ns}$ Body Diode Reverse Recovery Charge $Q_{rr}$ Reverse Recovery Fall Time $t_a$ $I_F = 1.3 \text{ A},  \text{dI/dt} = 100 \text{ A/µs}, T_J = 25 \text{ °C}$	Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C			1	А		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Pulse Diode Forward Current	1				4			
Body Diode Reverse Recovery Time $t_{rr}$ Body Diode Reverse Recovery Charge $Q_{rr}$ Reverse Recovery Fall Time $t_a$	Body Diode Voltage		I <sub>S</sub> = 1.3 A, V <sub>GS</sub> = 0 V		0.8	1.2	V		
Body Diode Reverse Recovery Charge $Q_{rr}$ $I_F = 1.3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ $0.0  0.0 $		1			20	40	ns		
Reverse Recovery Fall Time t <sub>a</sub> 16 ns			†		20	40	nC		
ns ns			$I_F = 1.3 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		16				

### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.

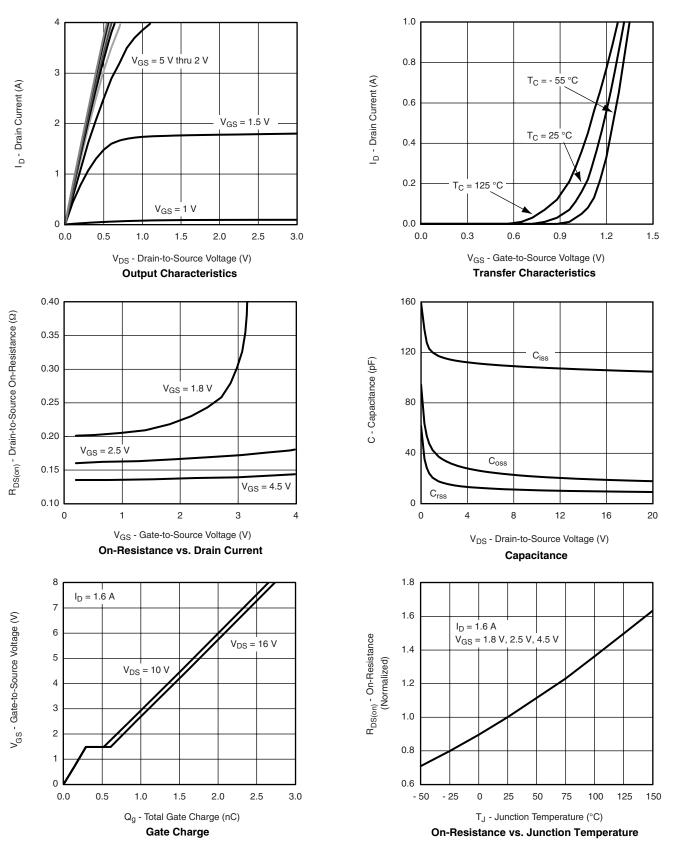
b. Guaranteed by design, not subject to production testing.







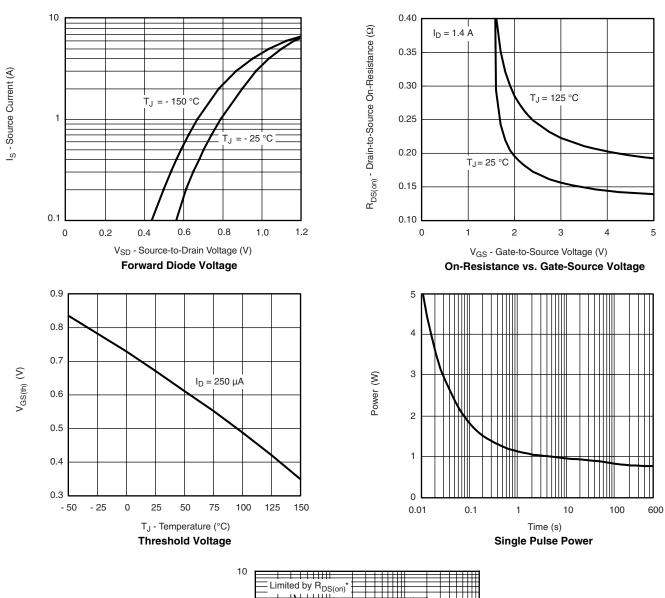
### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

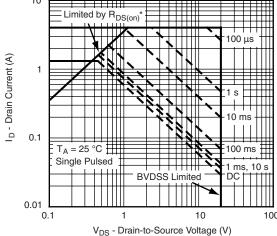


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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





\* V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

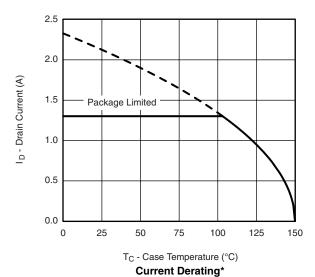
Safe Operating Area, Junction-to-Case

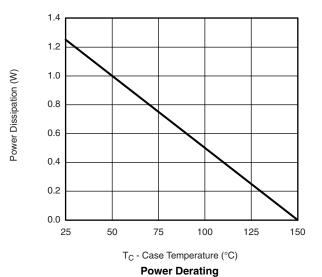






### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



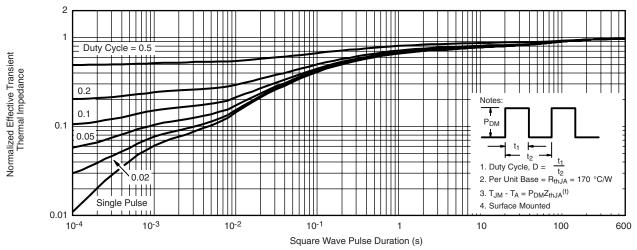


\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

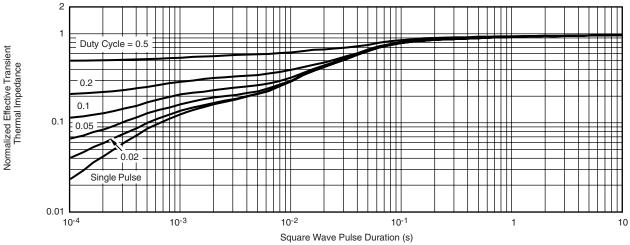
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppq?74296">www.vishay.com/ppq?74296</a>.



### **Legal Disclaimer Notice**

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